





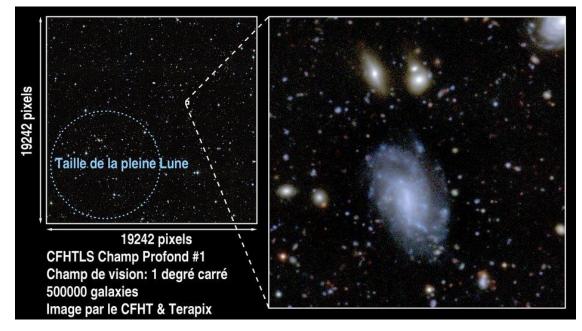


#### Transient detection using LSST-Stack

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## **Input and Validation Data**



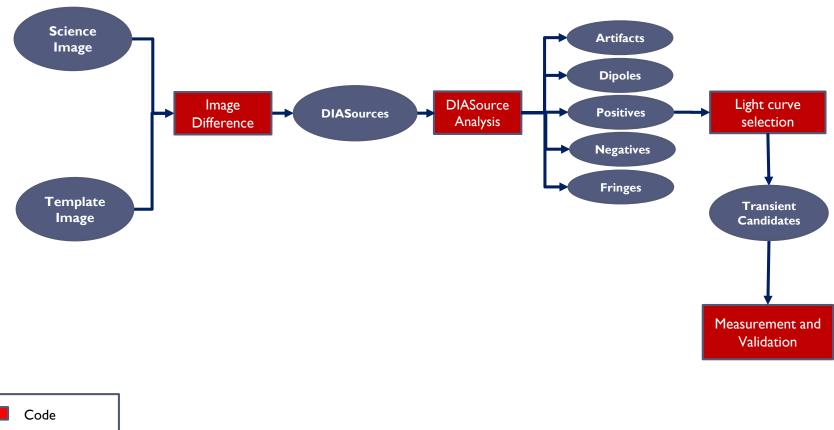
#### Input: CFHT-LS

- Deep Field D3
- Observations every 3-4 on filter r

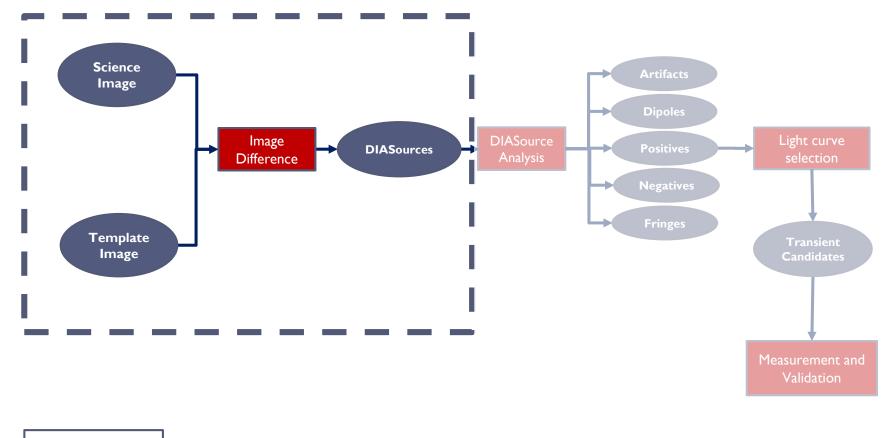
#### Validation: SNLS:

- SN data from three first years of CFHT-LS
- I7 SN IA identified in input dataset.

## **Transient Detection Pipeline**

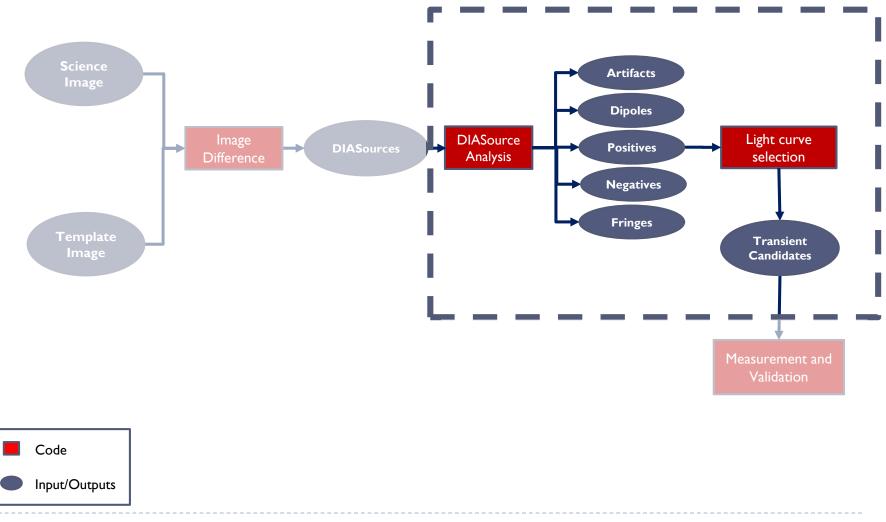


#### **Transient Detection Pipeline**



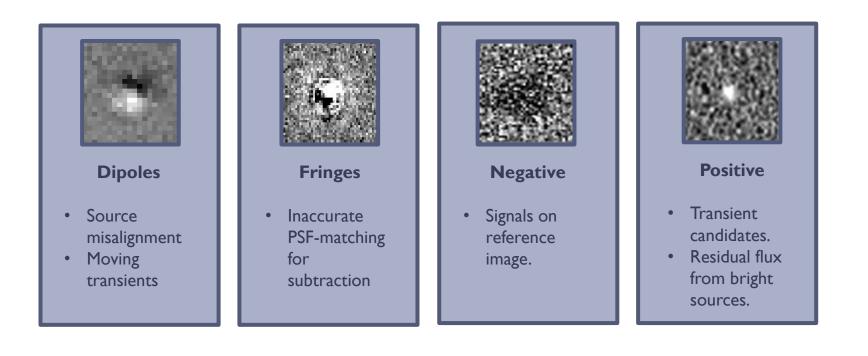


### **Transient Detection Pipeline**



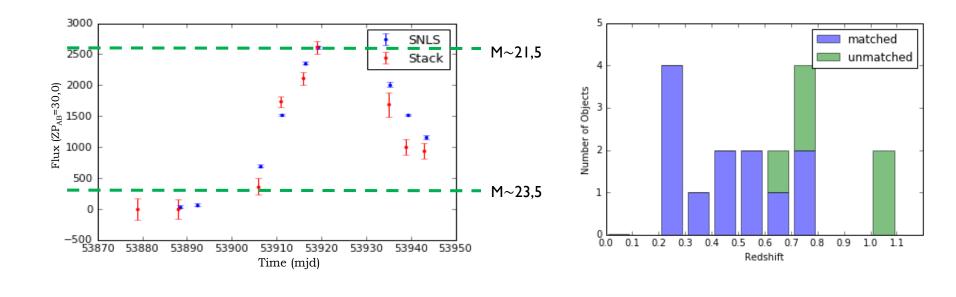
# **DIASource Characterization**

Detections are classified using data from detection footprint. Refinement of this classification involves more sophisticate algorithms.



## **Transient Detection Efficiency**

 Light curve comparison with SNLS SN IA and Pipeline candidates. 70% of SNLS SN Ia were matched (corresponding to z < 0.7).</li>



#### Perspectives

 Perform artifact classification using Machine Learning approximations/algorithm.

Reduce pool of artifacts and increase candidate accuracy by improving quality of subtractions.

Reprocess all CFHT Deep fields for transient detection.